



## Product Change Notification - LIAL-25ZCPA706

**Date:**

21 Mar 2018

**Product Category:**

8-bit PIC Microcontrollers

**Affected CPNs:****Notification subject:**

CCB 3257 Initial Notice: Qualification of MTAI as an additional assembly site for selected Atmel products available in 8L SOIJ package.

**Notification text:****PCN Status:**

Initial notification.

**PCN Type:**

Manufacturing Change

**Microchip Parts Affected:**

Please open one of the icons found on the Affected CPNs section above.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

**Description of Change:**

Qualification of MTAI as an additional assembly site for selected Atmel products available in 8L SOIJ package.

**Pre Change:**

Assembled in LPI using palladium coated copper wire with gold flash (CuPdAu) bond wire, CRM-1033BF die attach material

**Post Change:**

Assembled in LPI using palladium coated copper wire with gold flash (CuPdAu) bond wire, CRM-1033BF die attach material and assembled in MTAI using gold (Au) bond wire and 8390A die attach material

**Pre and Post Change Summary:**

|                           | Pre Change                               | Post Change                              |   |
|---------------------------|--|--|---|
| Assembly Site             | Lingsen Precision Industires, LTD. (LPI) | Lingsen Precision Industires, LTD. (LPI) | Microchip Technology Thailand HQ (MTAI) |
| Wire material             | CuPdAu                                   | CuPdAu                                   | Au                                      |
| Die attach material       | CRM-1033BF                               | CRM-1033BF                               | 8390A                                   |
| Molding compound material | G600                                     | G600                                     | G600                                    |
| Lead frame material       | C194                                     | C194                                     | C194                                    |

**Impacts to Data Sheet:**

None

**Change Impact:**

None

**Reason for Change:**



To improve on-time delivery performance by qualifying MTAI as additional assembly site.

**Change Implementation Status:**

In Progress

**Estimated Qualification Completion Date:**

April 2018

Note: Please be advised the qualification completion times may be extended because of unforeseen business conditions however implementation will not occur until after qualification has completed and a final PCN has been issued. The final PCN will include the qualification report and estimated first ship date. Also note that after the estimated first ship date guided in the final PCN customers may receive pre and post change parts.

**Time Table Summary:**

|                          | February 2018 |    |    |    |    | --> | April 2018 |    |    |    |
|--------------------------|---------------|----|----|----|----|-----|------------|----|----|----|
|                          | Workweek 06   | 07 | 08 | 09 | 10 |     | 14         | 15 | 16 | 17 |
| Initial PCN Issue Date   |               |    |    | X  |    |     |            |    |    |    |
| Qual Report Availability |               |    |    |    |    |     | X          |    |    |    |
| Final PCN Issue Date     |               |    |    |    |    |     | X          |    |    |    |

**Method to Identify Change:**

Traceability code

**Qualification Plan:**

Please open the attachments included with this PCN labeled as PCN\_#\_Qual Plan.

**Revision History:**

**March 1, 2018:** Issued initial notification.

**March 21, 2018:** Re-issued initial notification to update the post change and affected CPN list and to revised this initial notification to be issued to all affected customers.

The change described in this PCN does not alter Microchip’s current regulatory compliance regarding the material content of the applicable products.

**Attachment(s):**

[PCN\\_LIAL-25ZCPA706\\_QUAL PLAN.pdf](#)

Please contact your local **Microchip sales office** with questions or concerns regarding this notification.

**Terms and Conditions:**

If you wish to change your product/process change notification (PCN) profile please log on to our website at <http://www.microchip.com/PCN> sign into myMICROCHIP to open the myMICROCHIP home page, then select a profile option from the left navigation bar.

To opt out of future offer or information emails (other than product change notification emails), click here to go to [microchipDIRECT](#) and login, then click on the "My account" link, click on



"Update profile" and un-check the box that states "Future offers or information about Microchip's products or services."

Affected Catalog Part Numbers (CPN)

ATTINY13-20SQ  
ATTINY13-20SQR  
ATTINY13-20SU  
ATTINY13-20SU188  
ATTINY13-20SU365  
ATTINY13-20SUR  
ATTINY13-20SUR365  
ATTINY13A-SF  
ATTINY13A-SFR  
ATTINY13A-SFRA5  
ATTINY13A-SN  
ATTINY13A-SNR  
ATTINY13A-SU  
ATTINY13A-SU523  
ATTINY13A-SUR  
ATTINY13A-SURA2  
ATTINY13A-SURA4  
ATTINY13V-10SU  
ATTINY13V-10SUR  
ATTINY25-15ST  
ATTINY25-15ST1  
ATTINY25-15SZ  
ATTINY25-20SN  
ATTINY25-20SNR  
ATTINY25-20SU  
ATTINY25-20SUR  
ATTINY25V-10SN  
ATTINY25V-10SNR  
ATTINY25V-10SU  
ATTINY25V-10SUR  
ATTINY25V-15ST  
ATTINY45-15ST  
ATTINY45-15ST1  
ATTINY45-15SZ  
ATTINY45-20SU  
ATTINY45-20SUR  
ATTINY45V-10SU  
ATTINY45V-10SUR  
ATTINY45V-15ST  
ATTINY45VMAH-15ST  
ATTINY85-20SF  
ATTINY85-20SFR  
ATTINY85-20SU  
ATTINY85-20SUR  
ATTINY85V-10SU  
ATTINY85V-10SUR



**MICROCHIP**

## **QUALIFICATION PLAN SUMMARY**

**PCN#: LIAL-25ZCPA706**

**Date**

**February 07, 2018**

**Qualification of MTAI as an additional assembly site for selected Atmel products available in 8L SOIJ package.**

**Purpose:** Qualification of MTAI as an additional assembly site for selected Atmel products available in 8L SOIJ package.

**CCB No.:** 3257

|                          |                          |                   |
|--------------------------|--------------------------|-------------------|
| <b><u>Misc.</u></b>      | <b>Assembly site</b>     | MTAI              |
|                          | <b>BD Number</b>         | BDM-001676 rev. A |
|                          | <b>MP Code (MPC)</b>     | 355C4YC3XC01      |
|                          | <b>Part Number (CPN)</b> | ATTiny45-15SZ     |
| <b><u>Lead-Frame</u></b> | <b>Paddle size</b>       | 140x160 mils      |
|                          | <b>Material</b>          | CDA194            |
|                          | <b>Surface</b>           | Bare Cu paddle    |
|                          | <b>Treatment</b>         | Roughening        |
|                          | <b>Process</b>           | Stamped           |
|                          | <b>Lead-lock</b>         | No                |
|                          | <b>Part Number</b>       | 10100840          |
|                          | <b>Lead Plating</b>      | Matte Tin         |
| <b><u>Bond Wire</u></b>  | <b>Material</b>          | Au                |
| <b><u>Die Attach</u></b> | <b>Part Number</b>       | 8390A             |
|                          | <b>Conductive</b>        | Yes               |
| <b><u>MC</u></b>         | <b>Part Number</b>       | G600V             |
| <b><u>PKG</u></b>        | <b>PKG Type</b>          | SOIJ              |
|                          | <b>Pin/Ball Count</b>    | 8                 |
|                          | <b>PKG width/size</b>    | 208 mils          |
| <b><u>Die</u></b>        | <b>Die Thickness</b>     | 15 mils           |
|                          | <b>Die Size</b>          | 90.0 x 88.0 mils  |

| Test Name  | Conditions   | Sample Size   | Min. Qty of Spares per Lot (should be properly marked) | Qty of Lots | Total Units | Fail Accept Qty    | Est. Dur. Days | Test Site | Special Instructions   |
|--|--|---|--|-------------|-------------|--------------------|----------------|-----------|--|
| Standard Pb-free Solderability                     | JESD22B-102E; Perform 8 hours of steam aging for Matte tin finish and 1 hour steam aging for NiPdAu finish prior to testing.<br>Standard Pb-free: Matte tin/ NiPdAu finish, SAC solder, wetting temp 245°C for both SMD & through hole packages. | 22  | 5  | 1           | 27          | >95% lead coverage | 5              | MTAI      | Standard Pb-free solderability is the requirement. SnPb solderability (backward solderability- SMD reflow soldering) is required for any plating related changes and highly recommended for other package BOM changes. |
| Wire Bond Pull - WBP                               | CDF-AEC-Q100-001   | 5   | 0  | 1           | 5           | 0                  | 5              |           |  |
| Wire Bond Shear - WBS                              | CDF-AEC-Q100-001   | 5   | 0  | 1           | 5           | 0                  | 5              |           |  |
| External Visual                                    | Mil. Std. 883-2009/2010  | All devices prior to submission for qualification testing | 0  | 3           | ALL         | 0                  | 5              |           |  |
| HTSL (High Temp Storage Life)                      | +175°C (500hrs)<br>Electrical test pre and post stress at +25°C and hot temp at +85°C, +125°C.   | 45  | 5  | 3           | 150         | 0                  | 10             | MPH LI    | Spares should be properly identified.  |
| Preconditioning Required for surface mount devices | +150°C Bake for 24 hours, moisture loading requirements per MSL level + 3X reflow at peak reflow temperature per Jedec-STD-020E for package type. Electrical test pre and post stress at 25°C and hot temp +85°C, 125°C<br>MSL1 @ +260°C         | 231   | 15   | 3           | 738         | 0                  | 15             |           | Spares should be properly identified.  |
| HAST   | +130°C/85% RH for 96hrs. Electrical test pre and post stress at +25°C and hot temp at +85 °C, 125°C  | 77  | 5  | 3           | 246         | 0                  | 10             |           | Spares should be properly identified   |
| UHAST  | +130°C/85% RH for 96hrs. Electrical test pre and post stress at 25°C   | 77  | 5  | 3           | 246         | 0                  | 10             |           | Spares should be properly identified.  |



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ATTINY13A-SFR  
ATTINY13A-SFRA5  
ATTINY13A-SN  
ATTINY13A-SNR  
ATTINY13A-SU  
ATTINY13A-SU523  
ATTINY13A-SUR  
ATTINY13A-SURA2  
ATTINY13A-SURA4  
ATTINY13V-10SU  
ATTINY13V-10SUR  
ATTINY25-15ST  
ATTINY25-15ST1  
ATTINY25-15SZ  
ATTINY25-20SN  
ATTINY25-20SNR  
ATTINY25-20SU  
ATTINY25-20SUR  
ATTINY25V-10SN  
ATTINY25V-10SNR  
ATTINY25V-10SU  
ATTINY25V-10SUR  
ATTINY25V-15ST  
ATTINY45-15ST  
ATTINY45-15ST1  
ATTINY45-15SZ  
ATTINY45-20SU  
ATTINY45-20SUR  
ATTINY45V-10SU  
ATTINY45V-10SUR  
ATTINY45V-15ST  
ATTINY45VMAH-15ST  
ATTINY85-20SF  
ATTINY85-20SFR

ATTINY85-20SU  
ATTINY85-20SUR  
ATTINY85V-10SU  
ATTINY85V-10SUR